

SiPHYTM OC-48/STM-16 SONET/SDH TRANSCEIVER

Operation

Features

Complete low power, high speed, SONET/SDH transceiver with integrated limiting amp, CDR, CMU, and MUX/DEMUX

- Data Rates Supported: OC-48/STM-16 and 2.7 Gbps FEC
- Low Power Operation 1.2 W (typ)
- DSPLL[™] Based Clock Multiplier Unit w/ Selectable Loop Filter Bandwidths
- Integrated Limiting Amplifier
- Loss-of-Signal (LOS) Alarm
- **Diagnostic and Line Loopbacks**
- Applications
- Sonet/SDH Transmission Systems
- **Optical Transceiver Modules**

Sample Phase Adjustment

15 x 15 mm BGA Package

LVDS Parallel Interface

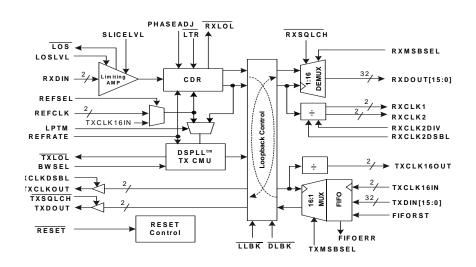
Sonet/SDH Test Equipment

Description

The Si5100 is a complete low-power transceiver for high-speed serial communication systems operating between 2.5 Gbps and 2.7 Gbps. The receive path consists of a fully integrated limiting amplifier, clock and data recovery unit (CDR), and 1:16 deserializer. The transmit path combines a low jitter clock multiplier unit (CMU) with a 16:1 serializer. The CMU uses Silicon Laboratories' DSPLL[™] technology to provide superior jitter performance while reducing design complexity by eliminating external loop filter components. To simplify BER optimization in long haul applications, programmable slicing and sample phase adjustment are supported.

The Si5100 operates from a single 1.8 V supply over the industrial temperature range (-40°C to 85°C).

Functional Block Diagram



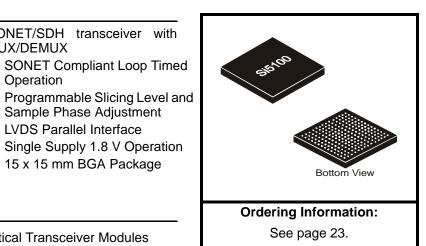




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Electrical Specifications

Table 1. Recommended Operating Conditions

				Max [*]	i i
T _A		-40	25	85	°C
V _{DD33}		1.71	_	3.47	V
V _{DD}		1.71	1.8	1.89	V
	V _{DD33} V _{DD}	V _{DD33} V _{DD}	V _{DD33} 1.71 V _{DD} 1.71	V _{DD33} 1.71 — V _{DD} 1.71 1.8	V _{DD33} 1.71 — 3.47

Figure 1. Differential Voltage Measurement (RXDIN, RXDOUT, RXCLK1, RXCLK2, TXDIN, TXDOUT, TXCLK0UT, TXCLK160UT, TXCLK16IN)

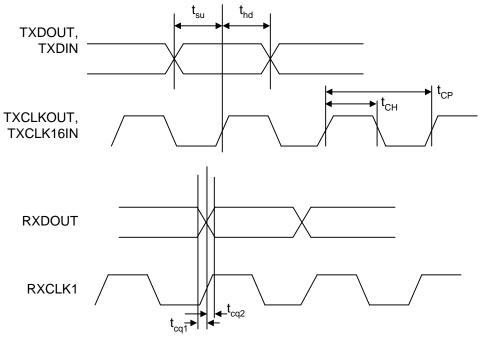


Figure 2. Data to Clock Delay



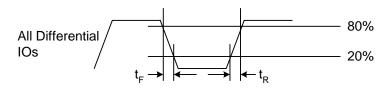


Figure 3. Rise/Fall Time Measurement

Table 2. DC Characteristics

 $(V_{DD} = 1.8 \text{ V} \pm 5\%, \text{ T}_{A} = -40^{\circ}\text{C} \text{ to } 85^{\circ}\text{C})$

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
Supply Current	I _{DD}		_	611	TBD	mA
Power Dissipation	PD		—	1.2	TBD	W
Voltage Reference (VREF)	V _{REF}	VREF driving 10 kΩ load	1.21	1.25	1.29	V
Common Mode Input Voltage (RXDIN)	V _{ICM}		TBD	0.1	TBD	V
Differential Input Voltage Swing (RXDIN)	V _{ID}	See Figure 1	10	_	1.0	mV (pk-pk)
Common Mode Output Voltage (TXDOUT, TXCLKOUT)	V _{OCM}		.8	0.9	1.0	V
Differential Output Voltage Swing (TXDOUT,TXCLKOUT), Differential pk-pk	V _{OD}	See Figure 1	800	1000	1200	mV (pk-pk)
LVPECL Input Voltage HIGH (REFCLK)	V _{IH}		1.975	2.3	2.59	V
LVPECL Input Voltage LOW (REFCLK)	V _{IL}		1.32	1.6	1.99	V
LVPECL Input Voltage Swing, Differential pk-pk (REFCLK)	V _{ID}	See Figure 1	250		2400	mV (pk-pk)
LVPECL Internally Generated Input Bias (REFCLK)	V _{IB}		1.6	1.95	2.3	V
LVDS Input High Voltage (TXDIN,TXCLK16IN)	V _{IH}				2.4	V
LVDS Input Low Voltage (TXDIN,TXCLK16IN)	V _{IL}		0.0			V
LVDS Input Voltage, Single Ended pk-pk (TXDIN,TXCLK16IN)	V _{ISE}		100	_	600	mV (pk-pk)
LVDS Output High Voltage (RXDOUT,RXCLK1,RXCLK2,TXCLK16OUT)	V _{OH1}	100 Ω Load Line-to-Line	TBD	_	1.475	mV
LVDS Output Low Voltage (RXDOUT,RXCLK1,RXCLK2,TXCLK16OUT)	V _{OL1}	100 Ω Load Line-to-Line	0.925	_	TBD	V
LVDS Output Voltage, Differential pk-pk (RXDOUT,RXCLK1,RXCLK2,TXCLK16OUT)	V _{OSE}	100 Ω Load Line-to-Line, Figure 1	500	_	800	mV (pk-pk)



Table 2. DC Characteristics (Continued)

 $(V_{DD} = 1.8 \text{ V} \pm 5\%, \text{ T}_{A} = -40^{\circ}\text{C to } 85^{\circ}\text{C})$

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
LVDS Common Mode Voltage (RXDOUT,RXCLK1,RXCLK2,TXCLK16OUT)	V _{CM}		1.125		1.275	V
Input Impedance (TXDIN, TXCLK16IN, REFCLK, RXDIN)	R _{IN}	Each input to common mode	42	50	58	Ω
Output Short to GND (RXDOUT,RXCLK1,RXCLK2, TXCLK16OUT, TXDOUT,TXCLKOUT)	I _{SC(-)}			25	TBD	mA
Output Short to V _{DD} (RXDOUT, RXCLK1, RXCLK2, TXCLK16OUT, TXDOUT, TXCLKOUT)	I _{SC(+)}		TBD	-100		μA
LVTTL Input Voltage Low	V_{IL2}	VDD33 = 3.3 V			0.8	V
(RXMSBSEL, RXCLK2DIV, RXCLK2DSBL, RXSQLCH, REFSEL, LTR, RESET, MODE16 TXCLKDSBL, FIFORST, TXSQLCH, BWSEL, TXMSBSEL, DLBK, LLBK, LPTM)		VDD33 = 1.8 V			0.7	
LVTTL Input Voltage High	V _{IH2}	VDD33 = 3.3 V	2.0			V
(RXMSBSEL, RXCLK2DIV, RXCLK2DSBL, RXSQLCH, REFSEL, LTR, RESET, MODE16 TXCLKDSBL, FIFORST, TXSQLCH, BWSEL, TXMSBSEL, DLBK, LLBK, LPTM)		VDD33 = 1.8 V	1.7			
LVTTL Input Low Current (RXMSBSEL, RXCLK2DIV, RXCLK2DSBL, RXSQLCH, REFSEL, LTR, RESET, MODE16 TXCLKDSBL, FIFORST, TXSQLCH, BWSEL, TXMSBSEL, DLBK, LLBK, LPTM)	Ι _{ΙL}				10	μΑ
LVTTL Input High Current (RXMSBSEL, RXCLK2DIV, RXCLK2DSBL, RXSQLCH, REFSEL, LTR, RESET, MODE16 TXCLKDSBL, FIFORST, TXSQLCH, BWSEL, TXMSBSEL, DLBK, LLBK, LPTM)	Ι _{ΙΗ}				10	μΑ
LVTTL Input Impedance (<u>RXMSBSEL</u> , RXCLK2 <u>DIV, RXCLK</u> 2DSBL, RXSQLCH, REFSEL, LTR, RESET, MODE16 TXCLKDSBL, FIFORST, TXSQLCH, BWSEL, TXMSBSEL, DLBK, LLBK, LPTM)	R _{IN}		10	_	_	kΩ
LVTTL Output Voltage Low	V _{OL2}	VDD33 = 1.8 V	_		0.4	V
(LOS, RXLOL, FIFOERR, TXLOL)		VDD33 = 3.3 V	_	_	0.4	
LVTTL Output Voltage High	V _{OH2}	VDD33 = 1.8 V	1.4			V
(LOS, RXLOL, FIFOERR, TXLOL)		VDD33 = 3.3 V	2.4			



Table 3. AC Characteristics (RXDIN, RXDOUT, RXCLK1, RXCLK2)

 $(V_{DD} = 1.8 \text{ V} \pm 5\%, \text{ T}_{A} = -40^{\circ}\text{C to } 85^{\circ}\text{C})$

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
Output Clock Frequency (RXCLK1)	f _{clkout}	See Figure 2	_	155	167	MHz
Duty Cycle (RXCLK1, RXCLK2)		tch/tcp, Figure 2	45	—	55	%
Output Rise and Fall Times (RXCLK1, RXCLK2, RXDOUT)	t _R ,t _F	Figure 3	_	50	_	ps
Data Invalid Prior to RXCLK1	t _{cq1}	Figure 2		—	200	ps
Data Invalid After RXCLK1	t _{cq2}	Figure 2	_	_	200	ps
Input Return Loss (RXIN)		100 kHz–2.5 GHz 2.5 GHz–4.0 GHz	18.7 TBD	_	_	dB dB
Slicing Adjust Dynamic Range		SLICELVL = 200-800 mV	-20		20	mV
Slicing Level Offset ¹ (referred to RXDIN)		SLICELVL = 200-800 mV	-500	_	500	μV
Slicing Level Accuracy		VSLICE	-5		5	%
Sampling Phase Adjustment ²		PHASEADJ = 200-800 mV	-22.5°		22.5°	
LOS Threshold Dynamic Range		LOSLVL = 200-800 mV	10	_	50	mV pk-pk
LOS Threshold Offset ³ (referred to RXDIN)		LOSLVL = 200-800 mV	-500	_	500	μV
LOS Threshold Accuracy		VLOS	-5		5	%

Note:

1. Slice level (referred to RXDIN) is calculated as follows: VSLICE = (SLICE_LVL - 0.4 • VREF)/15.

2. Sample Phase Offset is calculated as follows: PHASE OFFSET = 22.5°(PHASEADJ - 0.4 • VREF)/0.3

3. LOS Threshold voltage (referred to RXDIN) is calculated as follows: VLOS = 30 mV + (LOS_LVL - 0.4 • VREF)/15.



Table 4. AC Characteristics (TXCLK16OUT, TXCLK16IN, TXCLKOUT, TXDIN, TXDOUT) ($V_{DD} = 1.8 V \pm 5\%$, $T_A = -40^{\circ}$ C to 85° C)

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
TXCLKOUT Frequency	f _{clkout}		_	2.5	2.7	GHz
TXCLKOUT Duty Cycle		tch/tcp, Figure 2	45	—	55	%
Output Rise Time (TXCLKOUT, TXDOUT)	t _R	Figure 3	—	25		ps
Output Fall Time (TXCLKOUT, TXDOUT)	t _F	Figure 3	_	25		ps
TXCLKOUT Setup to TXDOUT	t _{su}	Figure 2	25	_	_	ps
TXCLKOUT Hold From TXDOUT	t _{hd}	Figure 2	25	_		ps
Output Return Loss		100 kHz–2.5 GHz 2.5 GHz–4.0 GHz	TBD TBD	-	_	dB dB
TXCLK16OUT Frequency	f _{CLKIN}	MODE16 = 1	_	622	667	MHz
	-	MODE16 = 0	—	155	167	
TXCLK16OUT Duty Cycle		tch/tcp, Figure 2	40		60	%
TXCLK16OUT Rise & Fall Times	t _R , t _F		100		300	ps
TXDIN Setup to TXCLK16IN	t _{DSIN}		—	—	300	ps
TXDIN Hold from TXCLK16IN	t _{DHIN}		—	—	300	ps
TXCLK16IN Frequency	f _{CLKIN}		—	155	167	MHz
TXCLK16IN Duty Cycle		tch/tcp, Figure 2	40	—	60	%
TXCLK16IN Rise & Fall Times	t _R , t _F		100		300	ps



Table 5. AC Characteristics (Receiver PLL) $(V_{DD} = 1.8 V \pm 5\%, T_A = -40^{\circ}C \text{ to } 85^{\circ}C)$

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
Jitter Tolerance	J _{TOL(PP)}	f = 600 Hz	15	30	—	UI _{PP}
		f = 6000 kHz	1.5	3.0	—	UI _{PP}
		f = 100 kHz	1.5	3.0		UI _{PP}
		f = 1 MHz	0.15	0.3		UI _{PP}
Acquisition Time	T _{AQ}		_	_	20	μS
Input Reference Clock Frequency	RC _{FREQ}	REFRATE = 1	—	155	167	MHz
		REFRATE = 0	_	78	83	MHz
Reference Clock Duty Cycle	RC _{DUTY}		40	50	60	%
Reference Clock Frequency Tolerance	RC _{TOL}		-100		100	ppm
Frequency Difference at which Receive PLL goes out of Lock (REFCLK compared to the divided down VCO clock)	LOL		TBD	600	1000	ppm
Frequency Difference at which Receive PLL goes into Lock (REFCLK compared to the divided down VCO clock)	LOCK		TBD	300	TBD	ppm
Note: Bellcore specifications: GR-137	7-CORE, Is	sue 5, December 1998.	- <u>L</u>	1	1	<u></u>

Table 6. AC Characteristics (Transmitter Clock Multiplier) (V_{DD} = 1.8 V \pm 5%, T_A = -40°C to 85°C)

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
Jitter Generation	J _{GEN(RMS)}	PRBS 23		0.005	TBD	UI _{RMS}
Jitter Transfer Bandwidth	J _{BW}	BWSEL = 0		_	6	kHz
		BWSEL = 1	—	_	25	kHz
Jitter Transfer Peaking			—	0.05	0.1	dB
Acquisition Time	T _{AQ}	Valid REFCLK		_	20	μs
Input Reference Clock Frequency	RC _{FREQ}	REFRATE = 1	—	155	167	MHz
		REFRATE = 0		78	84	MHz
Input Reference Clock Duty Cycle	RC _{DUTY}		40		60	%
Input Reference Clock Frequency Tolerance	RC _{TOL}		-100	_	100	ppm
Note: Bellcore specifications: GR-137	77-CORE, Iss	ue 5, December 1998.				



Table 7. Absolute Maximum Ratings

Symbol	Value	Unit
V _{DD}	-0.5 to TBD	V
V _{DD33}	-0.5 to 3.6	V
V _{DIF}	-0.3 to (V _{DD} + 0.3)	V
	±50	mA
T _{JCT}	-55 to 150	°C
T _{STG}	-55 to 150	°C
	275	°C
	TBD	V
	V _{DD} V _{DD33} V _{DIF}	$\begin{tabular}{ c c c c c } \hline V_{DD} & -0.5 \mbox{ to TBD} \\ \hline V_{DD33} & -0.5 \mbox{ to } 3.6 \\ \hline V_{DIF} & -0.3 \mbox{ to } (V_{DD} + 0.3) \\ \hline \pm 50 \\ \hline T_{JCT} & -55 \mbox{ to } 150 \\ \hline T_{STG} & -55 \mbox{ to } 150 \\ \hline 275 \\ \hline \end{tabular}$

maximum rating conditions for extended periods may affect device reliability.

Table 8. Thermal Characteristics

Parameter	Symbol	Test Condition	Value	Unit
Thermal Resistance Junction to Ambient	ΦJA	Still Air	38	°C/W



Functional Description

The Si5100 transceiver is a low power, fully integrated serializer/deserializer that provides significant margin to all SONET/SDH jitter specifications. The device operates from 2.5–2.7 Gbps making it suitable for OC-48/STM-16, and OC-48/STM-16 applications that use 15/14 forward error correction (FEC) coding. The low speed receive/transmit interface uses low-power LVDS inputs and outputs.

Receiver

The receiver within the Si5100 includes a precision limiting amplifier, jitter tolerant clock and data recovery unit (CDR), and 1:16 demultiplexer. In addition, programmable data slicing and sampling phase adjustment are provided to support bit-error-rate (BER) optimization for long haul applications.

Limiting Amplifier

The Si5100 incorporates a high sensitivity limiting amplifier with sufficient gain to directly accept the output of transimpedance amplifiers. High sensitivity is achieved by using a digital calibration algorithm to cancel out amplifier offsets. This algorithm achieves superior offset cancellation by using statistical averaging to remove noise that may degrade more traditional calibration routines.

The limiting amplifier provides sufficient gain to fully saturate with input signals that are less than 10 mV peak-to-peak differential. In addition, input signals that exceed 1 V peak-to-peak differential will not cause any performance degradation.

Loss-of-Signal (LOS) Detection

The limiting amplifier includes circuitry that generates a loss-of-signal (LOS) alarm when the input signal amplitude on RXDIN falls below an externally controlled threshold. The Si5100 can be configured to drive the LOS output low when the differential input amplitude drops below a threshold set between ~8 mV and 50 mV pk-pk differential. Approximately <u>3 dB</u> of hysteresis prevents unnecessary switching on LOS.

The LOS threshold is set by applying a voltage between 0.20 V and 0.80 V to the LOSLVL input. The voltage present on LOSLVL maps to an input signal threshold as follows:

$$V_{LOS} = \frac{(V_{LOSLVL} - 0.4xVREF)}{15} + 30 \text{ mV}$$

 V_{LOS} is the differential pk-pk LOS threshold referred to the RXDIN input, V_{LOSLVL} is the voltage applied to the LOSLVL pin, and VREF is reference voltage output on

the VREF pin.

The LOS detection circuitry is disabled by tieing the LOSLVL input to the supply (VDD). This forces the LOS output high.

Slicing Level Adjustment

To support applications that require BER optimization, the limiting amplifier provides circuitry that supports adjustment of the 0/1 decision threshold (slicing level) over a range of ± 20 mV when referred to the internally biased RXDIN input. The slicing level is set by applying a voltage between 0.20 V and 0.80 V to the SLICELVL input. The voltage present on SLICELVL sets the slicing level as follows:

$$V_{LEVEL} = \frac{(V_{SLICE} - 0.4xVREF)}{15}$$

 V_{LEVEL} is the slicing level referred to the RXDIN input, V_{SLICE} is the voltage applied to the SLICE_LVL pin, and VREF is reference voltage output on the VREF pin.

The slicing level adjustment may be disabled by tieing the SLCLVL input to the supply (VDD). When slicing is disabled, the slicing offset is set to 0.0 V relative to internally biased input common mode voltage for RXDIN.

Clock and Data Recovery (CDR)

The Si5100 uses an integrated CDR to recover clock and data from a non-return to zero (NRZ) signal input on RXDIN. The recovered data clock is used to regenerate the incoming data by sampling the output of the limiting amplifier at the center of the NRZ bit period. The recovered clock and data is then deserialized by a multiplexer that can be configured to operate in either 1:16 or 1:4 mode. The deserialized data is output via a LVDS compatible low speed interface (RXDOUT[15:0], RXCLK1, and RXCLK2).

Sample Phase Adjustment

In applications where it is not desirable to recover data by sampling in the center of the data eye, the Si5100 supports adjustment of the CDR sampling phase across the NRZ data period. When sample phase adjustment is enabled, the sampling instant used for data recovery can be moved over a range of $\pm 22.5^{\circ}$ relative to the center of the incoming NRZ bit period. Adjustment of the sampling phase is desirable when data eye distortions are introduced by the transmission medium.

The sample phase is set by applying a voltage between 0.20 V and 0.80 V to the PHASEADJ input. The voltage present on PHASEADJ maps to sample phase offset as follows:



$$PhaseOffset = \frac{22.5^{\circ}x(V_{PHASE} - 0.4xVREF)}{0.30}$$

Phase Offset is the sampling offset in degrees from the center of the data eye, V_{PHASE} is the voltage applied to the PHASEADJ pin, and VREF is reference voltage output on the VREF pin. A positive phase offset will adjust the sampling point to lead the default sampling point in the center of the data eye, and a negative phase offset will adjust the sampling point to lag the default sampling point.

Data recovery using a sampling phase offset is disabled by tieing the PHASEADJ input to the supply (VDD). This forces a phase offset of 0° to be used for data recovery.

Receiver Lock Detect

The Si5100 provides lock-detect circuitry that indicates whether the PLL has achieved frequency lock with the incoming data. This circuit compares the frequency of a divided down version of the recovered clock with the frequency of the supplied reference clock (REFCLK). If the recovered clock frequency deviates from that of the reference clock by the amount specified in Table 5 on page 9, the PLL is declared out of lock, and the loss-oflock (RXLOL) pin is asserted. In this state, the PLL will try to reacquire lock with the incoming data stream. During reacquisition, the recovered clock frequency (RXCLK1 and RXCLK2) will drift over a ±1000 ppm range relative to the supplied reference clock. The RXLOL output will remain asserted until the recovered clock frequency is within the REFCLK frequency by the amount specified in Table 5 on page 9.

Lock-to-Reference

In applications where it is desirable to maintain a stable output clock during an alarm condition like loss-of-signal, the lock-to-reference input (LTR) can be used to force a stable output clock. When LTR is asserted, the CDR is prevented from acquiring the data signal and the CDR will lock the RXCLKOUT1 and RXCLKOUT2 outputs to the provided REFCLK. In typical applications, the LOS output would be tied to the LTR input to force a stable output clock.

Deserialization

The Si5100 deserializes the high speed input for output on a 16-bit parallel data bus RXDOUT[15:0]. The demultiplexer used for deserialization can be configured to output either 4 or 16 bit words via the MODE16 pin. The data words are output on RXDOUT synchronous with the rising edge of RXCLK1. This clock output is derived by dividing down the recovered clock to the output word rate. When the demultiplexer is configured to output 4-bit data words, the data is output on RXDOUT[3:0].

Serial Input to Parallel Output Relationship

The Si5100 provides the capability to select the order in which the received serial data is mapped to the parallel output bus RXDOUT[15:0]. The mapping of the receive bits to the output data word is controlled by the RXMSB-SEL input. If RXMSBSEL is tied low, the first bit received is output on RXDOUT0 and the following bits are output in order on RXDOUT1 through RXDOUT15. If RXMSBSEL is tied high, the first bit received is output on RXDOUT15 and the following bits are output in order on RXDOUT14 through RXDOUT0.

Auxiliary Clock Output

To support the widest range of system timing configurations, a second clock output is provided on RXCLK2. This output can be configured to provide a clock equal to either the parallel output word rate or 1/4th the output word rate. The divide factor used to generate RXCLK2 is controlled via the RXCLKDIV2 input as described in the Pin Description table. In applications which do not use RXCLK2, this output can be powered down by forcing the RSCLK2DSBL input high.

Data Squelch

During some system error conditions, such as LOS, it may be desirable to force the receive data output to zero in order to avoid propagation of erroneous data to the downstream processing circuitry. In these applications, the Si5100 provides a data squelching control input, RXSQLCH. When this input is active low, the data on RXDOUT will be forced to 0. Data squelch is disabled if the device is operating in diagnostic loopback mode (DLBK = 0).

Transmitter

The transmitter consists of a low jitter, clock multiplier unit (CMU) with a 16:1 serializer. The CMU uses a phase-locked loop (PLL) architecture based on Silicon Laboratories' proprietary DSPLL[™] technology. This technology is used to generate ultra-low jitter clock and data outputs that provide significant margin to the SONET/SDH specifications. The DSPLL architecture also utilizes a digitally implemented loop filter that eliminates the need for external loop filter components. As a result, sensitive noise coupling nodes that typically cause degraded jitter performance in crowded PCB environments are removed.

The DSPLL[™] also reduces the complexity and performance requirements of reference clock distribution strategies for OC-48/STM-16 optical port cards. This is achieved because the DSPLL provides selectable wideband and narrowband loop filter settings



that allow the user to set the jitter attenuation characteristics of the CMU to accommodate reference clock sources that have a high jitter content. Unlike traditional analog PLL implementations, the loop filter bandwidth is controlled by a digital filter inside the DSPLL and can be changed without any modification to external components.

DSPLL[™] Clock Multiplier Unit

The Si5100's clock multiplier unit (CMU) uses Silicon Laboratories' proprietary DSPLL technology to generate a low jitter, high frequency clock source capable of producing a high speed serial clock and data output with significant margin to the SONET/SDH specifications. This is achieved by using a digital signal processing (DSP) algorithm to replace the loop filter commonly found in analog PLL designs. This algorithm processes the phase detector error term and generates a digital control value to adjust the frequency of the voltage controlled oscillator (VCO). Because external loop filter components are not required, sensitive noise entry points are eliminated, thus making the DSPLL less susceptible to board-level noise sources. Therefore, SONET/SDH jitter compliance is easier to attain in the application.

Programmable Loop Filter Bandwidth

The digitally implemented loop filter allows for two bandwidth settings that provide either wideband or narrowband jitter transfer characteristics. The filter bandwidth is selected via the BWSEL control input. In traditional PLL implementations, changing the loop filter bandwidth would require changing the values of external loop filter components.

In narrowband mode, a loop filter cutoff of 6 kHz is provided. This setting makes the Si5100 more tolerant to jitter on the reference clock source. As a result, the complexity of the clock distribution circuitry used to generate the physical layer reference clocks can be simplified without compromising jitter margin to the SONET/SDH specification.

In wideband mode, the loop filter provides a cutoff of 25 kHz. This setting is desirable in applications where the reference clock is provided by a low jitter source like the Si5364 Clock Synchronization IC or Si5320 Precision Clock Multiplier/Jitter Attenuator IC. This allows the DSPLL to more closely track the precision reference source resulting in the best possible jitter performance.

Serialization

The Si5100 includes serialization circuitry that combines a FIFO with a parallel to serial shift

register. The device can be configured to serialize either 4 or 16 bit data words input on TXDIN[15:0]. Low speed data on the parallel input bus, TXDIN[15:0], is latched into the FIFO on the rising edge of TXCLK16IN. The data in the FIFO is clocked into the shift register by an output clock, TXCLK16OUT, that is produced by dividing down the high-speed transmit clock, TXCLKOUT, to match the parallel word rate. The highspeed serial output generated by clocking data out of the shift register using TXCLKOUT.

The TXCLK16OUT clock output is used to support data transfers between the Si5100 and upstream devices using a counter clocking scheme. The parallel interface is configured for either 16 or 4 bit data transfers via the MODE16 pin. When 4-bit data transfers are configured, TXDIN[3:0] are used.

Input FIFO

The Si5100 integrates a FIFO to decouple data transferred into the FIFO via TXCLK16IN from data transferred into the shift register via TXCLK16OUT. The FIFO is eight parallel words deep and accommodates any static phase delay that may be introduced between TXCLK16OUT and TXCLK16IN in counter clocking schemes. Further, the FIFO will accommodate a phase drift or wander between TXCLK16IN and TXCLK16OUT of up to three parallel data words.

The FIFO circuitry indicates an overflow or underflow condition by asserting FIFOERR high. This output can be used to recenter the FIFO read/write pointers by tieing it directly to the FIFORST input. The Si5100 will also recenter the read/write pointers after the device's power on reset, external reset via RESET, and each time the DSPLL transitions from an out of lock state to a locked state (TXLOL transitions from low to high).

Parallel Input To Serial Output Relationship

The Si5100 provides the capability to select the order in which data on the parallel input bus is transmitted serially. Data on this bus can be transmitted MSB first or LSB first depending on the setting of TXMSBSEL. If TXMSBSEL is tied low, TXDIN0 is transmitted first followed in order by TXDIN1 through TXDIN15. If TXMSBSEL is tied high, TXDIN15 is transmitted first followed in order by TXDIN14 through TXDIN0. This feature simplifies board routing when ICs are mounted on both sides of the PCB.

Transmit Data Squelch

To prevent the transmission of corrupted data into the network, the Si5100 provides a control pin that can be used to force TXDOUT to 0. By driving TXSQLCH low, the high speed serial output, TXDOUT will be forced to 0. Transmit data squelching is disabled when the device is in line loopback mode (LLBK = 0).



Clock Disable

The Si5100 provides a clock disable pin, TXCLKDSBL, that is used to disable the high-speed serial data clock output, TXCLKOUT. When the TXCLKDSBL pin is asserted, the positive and negative terminals of CLKOUT are tied to 1.5 V through 50 Ω on-chip resistors. This feature is used to reduce power consumption in applications that do not use the high speed transmit data clock.

Loop Timed Operation

The Si5100 can be configured to provide SONET/SDH compliant loop timed operation. When LPTM is asserted high, the transmit clock and data timing is derived from the recovered clock output by the CDR. This is achieved by dividing down the recovered clock and using it as a reference source for the transmit CMU. This will produce a transmit clock and data that are locked to the timing recovered from the received data path. In this mode, a narrow band loop filter setting is recommended.

Diagnostic Loopback

The Si5100 supports diagnostic loopback which establishes a loopback path from the serializer output to the deserializer input. This provides a mechanism for looping back data input via the low speed transmit interface TXDIN to the low speed receive data interface RXDOUT. This mode is enabled by forcing DLBK low.

Line Loopback

The Si5100 supports line loopback which establishes a loopback path from the high speed receive input to the high speed transmit output. This provides a mechanism for looping back the high-speed clock and data recovered from RXDIN to the transmit data output TXDOUT and clock TXCLKOUT. This mode is enabled by forcing LLBK low.

Bias Generation Circuitry

The Si5100 makes use of two external resistors, RXREXT and TXREXT, to set internal bias currents for the receive and transmit sections of the Si5100. The external resistors allows precise generation of bias currents that significantly reduce power consumption. The bias generation circuitry requires $3.09 \text{ k}\Omega$ (1%) resistors connected between RXREXT/TXREXT and GND.

Reference Clock

The Si5100 is designed to operate with reference clock sources that are either 1/16th or 1/32nd the desired transceiver data rate. The device will support operation with data rates between ~2.5 Gbps and ~2.7 Gbps and the reference clock should be scaled accordingly. For example, to support 2.67 Gbps operation the reference clock source would be approximately 83 MHz or 167 MHz. The REFRATE input pin is used to configure the device for operation with one of the two supported reference clock submultiples of the data rate.

The Si5100 supports operation with two selectable reference clock sources. The first configuration uses an externally provided reference clock that is input via REFCLK. The second configuration uses the parallel data clock, TXCLK16IN, as the reference clock source. When using TXCLK16IN as the reference source, the narrowband loop filter setting in the CMU may be preferable to remove jitter that may be present on the data clock. The selection of reference clock source is controlled via the REFSEL input.

The CMU in the Si5100's transmit section multiplies up the provided reference to the serial transmit data rate. When the CMU has achieved lock with the selected reference, the TXLOL output will be driven high.The CDR in the receive section of the Si5100 uses a reference clock to center the PLL frequency so that it is close enough to the data frequency to achieve lock with the incoming data. When the CDR has locked to the data, RXLOL is driven high.

Reset

The Si5100 is reset by holding the RESET pin low for at least 1 μ s. When RESET is asserted low, the input FIFO pointers reset and the digital control circuitry initializes. When RESET transitions high to start normal operation, the CMU will be calibrated.

Voltage Reference Output

The Si5100 provides an output voltage reference that can be used by an external circuit to set the LOS threshold, slicing level, or sampling phase adjustment. One possible implementation would use a resistor divider to set the control voltage for LOSLVL, SLICELVL, or PHASEADJ. A second alternative would use a DAC to set the control voltage. Using this approach, VREF would be used to establish the range of a DAC output. The reference voltage is nominally 1.25 V.



Transmit Differential Output Circuitry

The Si5100 utilizes a current-mode logic (CML) architecture to drive the high speed serial output clock and data on TXCLKOUT and TXDOUT. An example of output termination with ac coupling is shown in Figure 4. In applications where direct dc coupling is possible, the 0.1 μ F capacitors may be omitted. The differential peak-to-peak voltage swing of the CML architecture is listed in Table 2 on page 5.

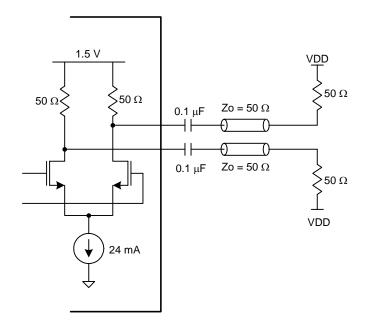


Figure 4. CML Output Driver Termination (TXCLKOUT, TXDOUT)



Si5100 Pinout: 195 BGA

14	13	12	11	10	9	8	7	6	5	4	3	2	1	_
RXDOUT [10]+	RXDOUT [8]–	RXDOUT [8]+	RXDOUT [6]–	RXDOUT [6]+	RXDOUT [4]–	RXDOUT [4]+	RXDOUT [2]–	RXDOUT [2]+	RXDOUT [0]–	RXDOUT [0]+	RX CLK[1]-	RX CLK[1]+		
RXDOUT [10]-	RXDOUT [9]–	RXDOUT [9]+	RXDOUT [7]–	RXDOUT [7]+	RXDOUT [5]–	RXDOUT [5]+	RXDOUT [3]–	RXDOUT [3]+	RXDOUT [1]-	RXDOUT [1]+	RX CLK[2]-	RX CLK[2]+	GND	
RXDOUT [12]+	RXDOUT [11]+	RXCLK2 DIV	RXREXT	NC	RXSQLCH	RXCLK2 DSBL	RSVD_ GND	RSVD_ GND	VREF	SLICELVL	LOSLVL	GND	GND	
RXDOUT [12]-	RXDOUT [11]-	RXMSB SEL	GND	PHASEADJ	RSVD_ GND	GND	RXDIN+							
RXDOUT [14]+	RXDOUT [13]+	RSVD_ GND	GND	VDD	VDD	VDD	VDD	VDD	VDD	GND	LTR	GND	RXDIN-	
RXDOUT [14]–	RXDOUT [13]-	DLBK	GND	VDD	VDD	VDD	VDD	VDD	VDD	RSVD_ GND	RXLOL	GND	GND	
REF CLK+	RXDOUT [15]+	MODE16	GND	VDD	VDD	VDD	VDD	VDD	VDD	RESET	LOS	GND	TXCLKOUT+	'
REF CLK-	RXDOUT [15]-	LLBK	GND	VDD	VDD	VDD	VDD	VDD	VDD	REFRATE	VDD33	GND	TXCLKOUT-	
TXDIN [14]+	TXDIN [15]+	LPTM	GND	VDD	VDD	VDD	VDD	VDD	VDD	GND	GND	GND	GND	
TXDIN [14]–	TXDIN [15]-	TXCLK DSBL	GND	VDD	VDD	VDD	VDD	VDD	VDD	RSVD_ GND	FIFOERR	GND	TXDOUT+	
TXDIN [12]+	TXDIN [13]+	REFSEL	GND	NC	TXREXT	GND	TXDOUT-							
TXDIN [12]-	TXDIN [13]-	TXSQLCH	RSVD_ GND	RSVD_ GND	TXMSB SEL	RSVD_ GND	BWSEL	FIFORST	TXLOL	GND	GND	GND	GND	
TXDIN [11]+	TXDIN [11]-	TXDIN [9]+	TXDIN [9]-	TXDIN [7]+	TXDIN [7]-	TXDIN [5]+	TXDIN [5]-	TXDIN [3]+	TXDIN [3]-	TXDIN [1]+	TXDIN [1]-	TXCLK16 IN+	5 TXCLK16 IN-	
TXDIN [10]+	TXDIN [10]-	TXDIN [8]+	TXDIN [8]–	TXDIN [6]+	TXDIN [6]–	TXDIN [4]+	TXDIN [4]–	TXDIN [2]+	TXDIN [2]-	TXDIN [0]+	TXDIN [0]-	TXCLK16 OUT+	OUT-	

Bottom View

Figure 5. Si5100 Pin Configuration (Bottom View)



	1	2	3	4	5	6	7	8	9	10	11	12	13	14
A		RX CLK[1]+	RX CLK[1]-	RXDOUT [0]+	RXDOUT [0]-	RXDOUT [2]+	RXDOUT [2]-	RXDOUT [4]+	RXDOUT [4]–	RXDOUT [6]+	RXDOUT [6]–	RXDOUT [8]+	RXDOUT [8]-	RXDOUT [10]+
В	GND	RX CLK[2]+	RX CLK[2]–	RXDOUT [1]+	RXDOUT [1]–	RXDOUT [3]+	RXDOUT [3]–	RXDOUT [5]+	RXDOUT [5]–	RXDOUT [7]+	RXDOUT [7]–	RXDOUT [9]+	RXDOUT [9]–	RXDOUT [10]-
С	GND	GND	LOSLVL	SLICELVL	VREF	RSVD_ GND	RSVD_ GND	RXCLK2 DSBL	RXSQLCH	NC	RXREXT	RXCLK2 DIV	RXDOUT [11]+	RXDOUT [12]+
D	RXDIN+	GND	RSVD_ GND	PHASE ADJ	GND	RXMSB SEL	RXDOUT [11]-	RXDOUT [12]–						
E	RXDIN-	GND	LTR	GND	VDD	VDD	VDD	VDD	VDD	VDD	GND	RSVD_ GND	RXDOUT [13]+	RXDOUT [14]+
F	GND	GND	RXLOL	RSVD_ GND	VDD	VDD	VDD	VDD	VDD	VDD	GND	DLBK	RXDOUT [13]-	RXDOUT [14]-
G	TXCLKOUT+	GND	LOS	RESET	VDD	VDD	VDD	VDD	VDD	VDD	GND	MODE16	RXDOUT [15]+	REF CLK+
Н	TXCLKOUT-	GND	VDD33	REFRATE	VDD	VDD	VDD	VDD	VDD	VDD	GND	LLBK	RXDOUT [15]–	REF CLK-
J	GND	GND	GND	GND	VDD	VDD	VDD	VDD	VDD	VDD	GND	LPTM	TXDIN [15]+	TXDIN [14]+
к	TXDOUT+	GND	FIFOERR	RSVD_ GND	VDD	VDD	VDD	VDD	VDD	VDD	GND	TXCLK DSBL	TXDIN [15]-	TXDIN [14]-
L	TXDOUT-	GND	TXREXT	NC	GND	REFSEL	TXDIN [13]+	TXDIN [12]+						
М	GND	GND	GND	GND	TXLOL	FIFORST	BWSEL	RSVD_ GND	TXMSB SEL	RSVD_ GND	RSVD_ GND	TXSQLCH	TXDIN [13]-	TXDIN [12]-
N	TXCLK16 IN-	TXCLK16 IN+	TXDIN [1]-	TXDIN [1]+	TXDIN [3]-	TXDIN [3]+	TXDIN [5]-	TXDIN [5]+	TXDIN [7]–	TXDIN [7]+	TXDIN [9]-	TXDIN [9]+	TXDIN [11]-	TXDIN [11]+
Ρ	TXCLK16 OUT-	TXCLK16 OUT+	TXDIN [0]-	TXDIN [0]+	TXDIN [2]-	TXDIN [2]+	TXDIN [4]-	TXDIN [4]+	TXDIN [6]–	TXDIN [6]+	TXDIN [8]-	TXDIN [8]+	TXDIN [10]-	TXDIN [10]+
Ρ														

Top View

Figure 6. Si5100 Pin Configuration (Transparent Top View)



Pin Descriptions: Si5100

Pin Number(s)	Name	I/O	Signal Level	Description	
M7	BWSEL	I	LVTTL	Bandwidth Select DSPLL. This input selects loop bandwidth of the DSPLL. BWSEL = 0: Loop bandwidth set to 6 kHz. BWSEL = 1: Loop bandwidth set to 25 kHz.	
F12	DLBK	I	LVTTL	Diagnostic Loopback. When this input is active low the transmit clock and data are looped back for output on RXD- OUT, RXCLK1 and RXCLK2. This pin should b held high for normal operation.	
КЗ	FIFOERR	0	LVTTL	FIFO Error. This output is driven high when a FIFO over- flow/underflow has occurred. This output will stick high until reset by asserting FIFORST.	
M6	FIFORST	I	LVTTL	FIFO RESET. This input when asserted high resets the read/write FIFO pointers to their initial state.	
B1, C1–2, D2, D5–11, E4, E11, E2, F11, F1–2, G11, G2, H11, H2, J11, J1–4, K11, K2, L5–11, L2, M1–4	GND	GND		Supply Ground.	
H12	LLBK	I	LVTTL	Line Loopback. When this input is active low the recovered clock and data are looped back for output on TXD- OUT, and TXCLKOUT. This pin should be held high for normal operation.	
G3	LOS	Ο	LVTTL	Loss-of-Signal. This output is driven low when the peak-to-peak signal amplitude is below threshold set via LOSLVL.	
C3	LOSLVL	I		LOS Threshold Level. Applying an analog voltage to this pin allows adjustment of the Threshold used to declare LOS. Tieing this inp <u>ut high disables LOS detec-</u> tion and forces the LOS output high.	



Pin Number(s)	Name	I/O	Signal Level	Description	
J12	LPTM	Ι	LVTTL	Loop Timed Operation. When this input is forced high, the recovered clock from the receiver is divided down and used as the reference source for the transmit CMU. The narrowband setting for the DSPLL CMU will be sufficient to provide SONET compliant jitter generation and transfer on the transmit data and clock outputs (TXDOUT,TXCLKOUT). This pin should be held low for normal operation.	
E3	LTR	I	LVTTL	Lock-to-Reference. This input forces a stable output clock by locking RXCLK1 and RXCLK2 to the provided reference. Driving LTR low activates this feature.	
G12	MODE16	Ι	LVTTL	MUX/DEMUX Mode. This input configures the multiplexer/demultiplexer to operate with either 4 or 16 bit parallel data words. When this input is forced high, the device is configured for 16-bit parallel word transfers on RXDOUT[15:0] and TXDIN[15:0]. When this input is forced low, the multiplexer/demultiplier operates with 4-bit word transfers on RXDOUT[3:0] and TXDIN[3:0].	
C10, L4	NC			No Connect. Reserved for device testing leave electrically unconnected.	
D4	PHASEADJ	I		Sampling Phase Adjust. Applying an analog voltage to this pin allows adjustment of the sampling phase across the data eye. Tieing this input high nominally centers the sampling phase.	
G14, H14	REFCLK+, REFCLK–	Ι	LVPECL	Differential Reference Clock. The reference clock sets the operating frequency of the PLL used to generate the high speed transmit clock. In addition, REFCLK sets the initial operating frequency used by the onboard PLL for clock and data recovery. The Si5100 will operate with reference clock frequencies that are either 1/16 or 1/32 the serial data rate (nominally 155 MHz or 78 MHz).	
H4	REFRATE	I	LVTTL	Reference Clock Select. This input configures the Si5100 to operate with one of two reference clock frequencies. If REFRATE is held high, the device requires a ref- erence clock that is 1/16 the serial data rate. If REFRATE is low, a reference clock at 1/32 the serial data rate is required.	



Pin Number(s)	Name	I/O	Signal Level	Description	
L12	REFSEL	I	LVTTL	Reference Clock Selection.	
				This inputs selects the reference clock source used by the CMU. When REFSEL = 0, the low speed data input clock, TXCLK16IN, is used as the CMU reference. When REFSEL = 1, the ref- erence clock provided on REFCLK is used.	
G4	RESET	Ι	LVTTL	Device Reset. Forcing this input low for a at least 1 μs will cause a device reset. For normal operation, this pin should be held high.	
C6–7, D3, E12,	RSVD_GND			Reserved Tie to Ground.	
F4, K4, M8, M10–11,				Must tie directly to GND for proper operation.	
A2–3	RXCLK1+,	0	LVDS	Differential Clock Output 1.	
	RXCLK1-			The clock recovered from the signal present on RXDIN is divided down to the parallel output word rate and output on RXCLK1. In the absence of data, a stable clock on RXCLK1 can be maintained by asserting LTR.	
B2–3	RXCLK2+,	0	LVDS	Differential Clock Output 2.	
	RXCLK2-			An auxiliary output clock is provided on this pin that is equivalent to, or a submultiple of, the out- put word rate. The divide factor used in generat- ing RXCLK2 is set via RXCLK2DIV.	
C12	RXCLK2DIV	I	LVTTL	Clock Divider Select.	
				This input selects the divide factor used to gen- erate the RXCLK2 output. When this input is driven low, RXCLK2 is equal to the output word rate on RXDOUT. When driven high, RXCLK2 is 1/4th the output word rate.	
C8	RXCLK2DSBL	I	LVTTL	RXCLK2 Disable.	
				Driving this input high will disable the RXCLK2 output. This would be used to save power in applications that do not require an auxiliary clock.	
D1, E1	RXDIN+,	I	High Speed	Differential Data Input.	
	RXDIN-		Differential	Clock and data are recovered from the high speed data signal present on these pins.	
A4–14, B4–14,	RXDOUT[15:0]-,	0	LVDS	Differential Parallel Data Output.	
C13–14, D13– 14, E13–14, F13–14, G13, H13	RXDOUT[15:0]+			The data recovered from the signal present on RXDIN is demultiplexed and output as either a 4- bit or 16-bit parallel word via RXDOUT[15:0]. These outputs are updated on the rising edge of RXCLK1. The data word width is configured via the MODE16 input.	



Pin Number(s)	Name	I/O	Signal Level	Description	
F3	RXLOL	0	LVTTL	Loss-of-Lock. This output is driven low when the recovered clock frequency deviates from the reference clock by the amount specified in Table 5.	
D12	RXMSBSEL	Ι	LVTTL	Data Bus Receive Order.This determines the order of the received databits on the output bus.For RXMSBSEL = 0, the first data bit received isoutput on RXDOUT[0] and following data bits areoutput on RDOUT[1] through RXDOUT[15].For RXMSBSEL = 1, the first data bit is outputon RXDOUT[15] and following data bits are output on RXDOUT[14] through RXDOUT[0].	
C11	RXREXT			External Bias Resistor. This resistor is used by the receiver circuitry to establish bias currents within the device. This pin must be connected to GND through a $3.09 \text{ k}\Omega$ (1%) resistor.	
C9	RXSQLCH	I	LVTTL	Data Squelch. When this input is low the data on RXDOUT is forced to 0. Set high for normal operation.	
C4	SLICELVL	I		Slicing Level Adjustment. Applying an analog voltage to this pin allows adjustment of the slicing level applied to the input data eye. Tieing this input high nominally sets the slicing offset to 0.	
N1-2	TXCLK16IN–, TXCLK16IN+	I	LVDS	Differential Data Clock Input. The rising edge of this input clocks data present on TXDIN into the device.	
P1-2	TXCLK16OUT–, TXCLK16OUT+	0	LVDS	Divided Down Output Clock. This clock output is generated by dividing down the high speed output clock, TXCLKOUT, by a factor of 16. It is intended for use in counter clocking schemes that transfer data between the system ASIC and the Si5100.	
K12	TXCLKDSBL	I	LVTTL	High Speed Clock Disable When this input is high, the output driver for TXCLKOUT is disabled. In applications that do not require the output data clock, the output clock driver should be disabled to save power.	
G1, H1	TXCLKOUT+, TXCLKOUT–	0	CML	High Speed Clock Output. The high speed output clock, TXCLKOUT, is generated by the PLL in the clock multiplier unit. Its frequency is nominally 16 or 32 times the selected reference source.	



Pin Number(s)	Name	I/O	Signal Level	Description
J13–14, K13–14, L13–14, M13–14, N3–14, P3–14	TXDIN[15:0]–, TXDIN[15:0]+	I	LVDS	Differential Parallel Data Input. The 16-bit data word present on these pins is multiplexed into a high speed serial stream and output on TXDOUT. The data on these inputs is clocked into the device by the rising edge of TXCLK16IN.
K1, L1	TXDOUT+, TXDOUT–	Ο	CML	Differential High Speed Data Output. The 16-bit word input on TXDIN[15:0] is multi- plexed into a high speed serial stream that is output on these pins. Input data is multiplexed in sequence from TXDIN0 to TXDIN15 with TXDIN0 transmitted first. This output is updated by the rising edge of TXCLKOUT.
M5	TXLOL	0	LVTTL	CMU Loss-of-Lock. The output is asserted low when the CMU is not phase locked to the selected reference source.
M9	TXMSBSEL	I	LVTTL	Data Bus Transmit Order. For TXMSBSEL = 0, data on TXDIN[0] is trans- mitted first followed by TXDIN[1] through TXDIN[15]. For TXMSBSEL = 1, TXDIN[15] is transmitted first followed by TXDIN[14] through TXDIN[0].
L3	TXREXT			External Bias Resistor. This resistor is used by the transmitter circuitry to establish bias currents within the device. This pin must be connected to GND through a $3.09 \text{ k}\Omega (1\%)$ resistor.
M12	TXSQLCH	Ι	LVTTL	Transmit Data Squelch.If TXSQLCH is asserted low, the output datastream on TXDOUT will be forced to 0s. IfTXSQLCH = 1, TX squelching is turned off.
E5–10, F5–10, G5–10, H5–10, J5–10, K5–10,	VDD	VDD	1.8 V	Supply Voltage. Nominally 1.8 V.
НЗ	VDD33	VDD33	1.8 V or 3.3 V	Digital Output Supply. Must be tied to either 1.8 V or 3.3 V. When tied to 3.3 V, LVTTL compatible output voltage swings on RXLOL and LOS, TXLOL, FIFOERR are supported.
C5	VREF	0	Voltage Ref	Voltage Reference. The Si5100 provides an output voltage reference that can be used by an external circuit to set the LOS threshold, slicing level, or sampling phase adjustment. The equivalent resistance between this pin and GND should not be less than 10 k Ω . The reference voltage is nominally 1.25 V.



Ordering Guide

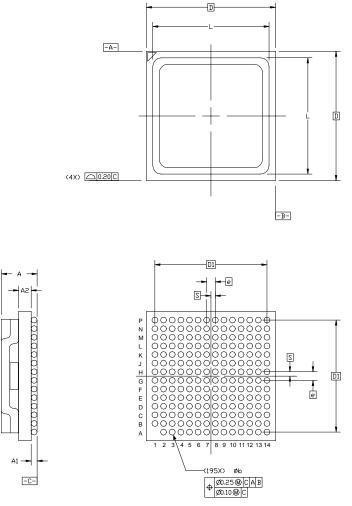
Part Number	Package	Temperature
Si5100-BC	195 BGA	–40°C to 85°C

Table 9. Ordering Guide



Package Outline

Figure 7 illustrates the package details for the Si5100. Table 10 lists the values for the dimensions shown in the illustration.





Symbol	Min	Nom	Max
А	3.50	3.65	3.80
A1	0.65	0.70	0.75
A2	1.35	1.45	1.55
b	0.65	0.70	0.75
D	14.90	15.00	15.10
D1		13.00	—
е	—	1.00	—
L	12.95	13.00	13.05
S		0.50	

Table 10. Package Diagram Dimensions (mm)



NOTES:



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